## Notice of References Cited

Application/Control No. 10/787,181	Applicant(s)/Patent Under Reexamination TSUNAKAWA ET AL.	
Examiner	Art Unit	
Henry M Johnson, III	3739	Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2004/0098072 A1	05-2004	Tone et al.	607/096
	В	US-2004/0138729 A1	07-2004	Ladmer, Andrea	607/109
	С	US-6,824,557 B2	11-2004	Tone et al.	607/114
	D	US-6,823,860 B2	11-2004	lgaki et al.	126/263.05
	Е	US-6,629,964 B1	10-2003	Ono et al.	604/304
	F	US-6,436,128 B1	08-2002	Usui, Akio	607/96
	G	US-6,409,746 B1	06-2002	Igaki et al.	607/109
	Н	US-6,261,314 B1	07-2001	Rich, Patricia Lyn	607/109
	ı	US-5,938,693 A	08-1999	Carminucci, Robert N.	607/104
	J	US-4,753,241 A	06-1988	Brannigan et al.	607/112
	κ.	US-4,205,685 A	06-1980	Yoshida et al.	607/96
	Ļ	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.